Pre-breakdown Arcing and Electrostatic Discharge in Dielectrics under High DC Electric Field Stress

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Pre-breakdown Arcing and Electrostatic Discharge in Dielectrics under High DC Electric Field Stress

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Abstract—Highly disordered insulating materials exposed to high electric fields will, over time, degrade and fail, potentially causing catastrophic damage to devices. Step-up to electrostatic discharge (ESD) tests were performed for two common polymer dielectrics, low density polyethylene and polyimide. Pre-breakdown transient current spikes or arcs were observed, using both slow and high speed detection. These pre-ESD discharge phenomena are explained in terms of breakdown modes and defect generation on a microscopic scale. The field at which pre-breakdown arcing begins was compared to the onset field for electrostatic discharge at which complete breakdown occurs for each material studied. We present evidence that these two threshold fields are the same. Thus, the important parameter to consider in design may not be the maximum field for breakdown, as much as the defect structure in the materials and the field where pre-breakdown arcing begins in a material.

Keywords—electrostatic discharge; arcing; breakdown; charging, partial discharge, dielectric materials

I. INTRODUCTION

Enhanced understanding of DC aging based on expanded experimental studies is of critical importance not only to understand the physics of highly disordered insulating materials (HDIM), but also for applications in spacecraft charging, high voltage DC power transmission and switching, thin film dielectrics, and semiconductor devices and sensors[1-3]. Recent literature on DC power cable aging calls for better models and more data on the details of electrical ageing in HDIM under DC high electric fields, especially with regards to finding a DC equivalent for AC partial discharge diagnostic tests[4-7].

High electric field stress phenomena associated with electrostatic discharge (ESD) were studied for low density polyethylene (LDPE) and polyimide. ESD is observed over a range of fields, extended well below the average ESD field down to a minimum field termed the onset field, $F_{onset}$. For these polymers very short duration, unsustained arcing—termed here as pre-breakdown arcing—was also observed at fields well below the average breakdown field for each material, down to a minimum field termed the onset field, $F_{Pre-arcing}$. We propose that minimum field at which ESD begins to occur can be correlated to the initial fields for pre-breakdown arcing.

Our experimental results are explained in terms of a dual-defect thermodynamic mean field trapping model [8]. This model characterizes electrical aging in terms of recoverable defects that can be thermally annealed and irrecoverable defects with higher energies such as bond breaking. We use this model to make a statistical comparison of our arcing and ESD data.

II. EXPERIMENTATION

The critical field for ESD breakdown was determined by performing step-up tests of the voltage across ~25 µm samples and monitoring the leakage current [8]. A simple parallel-plate capacitor geometry was used, under high vacuum, to achieve field strengths of up to 590 MV/m [9, 10]. Current was monitored at ~2 Hz with an ammeter and ~10 kHz with an oscilloscope. Voltage was increased incrementally at constant rate of $\Delta V_{seg}$=20 V at $A_{seg}$=3.5 up to 30 kV until complete breakdown occurred (see Fig. 1). Above breakdown (yellow region in Fig. 1) current increased linearly with the slope set by current limiting resistors in the circuit up through voltages where all samples have broken down (red region in Fig. 1). Prior to breakdown pre-breakdown arcing is observed with currents below breakdown currents at a given voltage (blue and yellow regions in Fig. 1).

LDPE samples from Goodfellow used had an average measured thickness of 29.7±2% µm, density of 0.92 g/cm$^3$ [11], an estimated crystallinity of 50% [12], an estimated peak fractional mass distribution of ~6·10$^9$ amu or ~2·10$^9$ C$_2$H$_4$ mers per chain[13,14], and a relative dielectric constant of 2.26 [11]. Samples of polyimide DuPont Kapton HN$^{TM}$ used had a 23.9±4% µm average measured thickness, density of 1.43±0.01 g/cm$^3$ [15], and a relative dielectric constant of 3.5 [15]. A single mer of polyimide has an atomic composition of C$_2$O$_3$N$_3$H$_{10}$ [15].

III. STATISTICAL ANALYSIS OF ELECTROSTATIC BREAKDOWNS

The electrical aging of HDIM is described by many publications as depending on the Gibbs free energy, bond destruction energy, or cohesion energy associated with internal defect creation due to local and applied electric fields [4,16-18]. The motion of charge carriers between defect sites either with or against an applied electric field can be modeled as a rate process similar to the hopping conductivity models of Miller and Abrahams or the standard Crine aging model which assume a single mean defect energy and density [4, 6, 19, 20]. Static voltage time endurance tests of LDPE strongly suggest a need for the inclusion of multiple defect species [8]. This
The extended model, Eq. (1), for the probability of breakdown due to two defect species \( P_{\text{Tot}}(\Delta t, F, T) = \sum_{i=A,B} P_{\text{def}}^i(\Delta t, F, T) \)

\[
P_{\text{def}}^i(\Delta t, F, T) = \frac{2k_b T}{\hbar / \Delta t} \sum_{i=A,B} \exp \left[ \frac{-\Delta G_{\text{def}}^i}{k_b T} \right] \sinh \left[ \frac{E - \epsilon^- e_i^2}{2N, k_b T} \right]
\]

Consider two defect species, one reversible and one irreversible (Types A and B respectively). Type A defects, \( \Delta G_{\text{def}}^A \) are on the order of \( k_b T \) for relevant temperatures and can be thermally annealed at a significant rate. The repair rate of these defects is strongly temperature dependent. Physically these could arise from weak van der Waals bonds, polymer chain kinks or kink pairs [16,21]. It is expected due to strong variations in the chain structure, rigidity and crosslinking that \( \Delta G_{\text{def}}^A \) will vary considerably for different polymers. Type B defects, \( \Delta G_{\text{def}}^B \) are associated with broken bonds such as carbon-carbon bonds of the \( \text{C}_2\text{H}_4 \) monomer alkane single bonds along the polymer chains that act as electron traps [16,20,22,23]. Since \( \Delta G_{\text{def}}^B \gg k_b T \) for all relevant \( T \), these defects have a negligible repair rate [4]. These broken bond \( (bb) \) energies have a dissociation energy of \( \Delta G_{\text{def}}^{bb} = 3.65 \text{ eV/bond} \). We do not expect \( \Delta G_{\text{def}}^B \) to vary greatly from one polymer to another because of the commonality of the carbon-carbon bonds.

We performed 89 LDPE and 36 Kapton step-up tests (Section II). Fig. 3 shows the fraction of breakdowns that occur versus the breakdown electric field. The shapes of these distributions suggest that simply a mean breakdown field with some uncertainty is an inadequate description of ESD breakdown fields. Eq. 1 applied to the step-up processes leads to a formula for the cumulative probability of breakdown after \( N_{\text{step}} = \frac{F \Delta \Phi}{\epsilon_0} \) voltage steps of \( \Delta V \) to field \( F \) across a sample with thickness \( D \) [8]. A first order approximation to this formula is a Weibull distribution [8].

\[
P^W(F) = 1 - \exp \left[ -\left( \frac{F}{F_{\text{def}}^W} \right)^\beta \right]
\]

where \( F_{\text{def}}^W \) approximates the field associated with the defect energy involved in breakdown. The fraction of total samples broken down versus breakdown field was fit to Eq. 2 and is shown in Fig. 3. For LDPE \( F_{\text{def}}^W = 293 \text{ MV/m} \) and \( \beta = 6.96 \). For Kapton \( F_{\text{def}}^W = 336 \text{ MV/m} \) and \( \beta = 10.9 \). We define the onset of breakdowns, \( F_{\text{onset}} \) as \( p^W(F_{\text{onset}}) = 0.0455 \). Similarly we define the field at which nearly all breakdowns have occurred, \( F_{\text{ESD}} \) as \( p^W(F_{\text{ESD}}) = 0.9545 \). In Figs. 3 and 4 \( F_{\text{onset}} \) to \( F_{\text{def}}^W \) defines the blue region, \( F_{\text{def}}^W \) to \( F_{\text{ESD}} \) defines the yellow region and the red region is defined as field values above \( F_{\text{ESD}} \). For LDPE \( F_{\text{onset}} = 189 \pm 6 \text{ MV/m} \) while \( F_{\text{ESD}} = 345 \pm 17 \text{ MV/m} \). For Kapton \( F_{\text{onset}} = 253 \pm 8 \text{ MV/m} \) while \( F_{\text{ESD}} = 373 \pm 11 \text{ MV/m} \). In Fig. 3 we see similar high field behavior which would be expected if Type B defects are roughly the same for each material. The blue regions in Fig. 3 associated with \( F_{\text{onset}} \) differ significantly corresponding to large differences in Type A defects. For Kapton, the sturdier of the two materials, we see that \( F_{\text{onset}} \) is comparatively higher than for LDPE.

IV. STATISTICAL ANALYSIS OF PRE-ARCING

A statistical analysis has been conducted of the common, short-duration, recoverable discharge events or pre-arcs observed during ESD test before complete breakdown occurs. The data discussed in this section are the results of the same step-up voltage tests discussed in Section III.

Typical threshold amplitudes for the smallest arcs observed above background noise in the ammeter data were 0.09 \( \mu \text{A} \) s for LDPE and 0.07 \( \mu \text{A} \) for polyimide. The pre-arcs measured with slow ammeters (see Fig. 1) are more frequent and of higher current amplitude at higher applied fields. This suggests that a correction for the measured arc rate is needed to correct for multiple short duration arcing events occurring within a single ~0.5 s data acquisition interval of the ammeters used in these experiments and are integrated and averaged by the ammeter. Typical discharge pulses observed with fast oscilloscopes are <5 \( \mu \text{s} \) duration (see Fig. 2). The estimated ammeter amplitude of a single arc is 0.15±0.05 \( \mu \text{A} \). Shapes of the distributions of the arc rates (see Fig. 4) are largely...
insensitive to the choice of the threshold values. The arcing rates measured with the ammeter were corrected for these multiple arcs per acquisition time by estimating the number of single arcs in higher current events as the measured current divided by the average single arc current.

Figure 4 shows a histogram of number of corrected pre-breakdown arcing events versus applied field divided by the average breakdown field for both LDPE and polyimide step-up tests. These frequency data are fit with a field-dependent Gaussian distribution

$$f(F) = \frac{f_0}{\sqrt{2\pi} \Delta F^*} \exp \left[ -\frac{(F - F_{\text{def}})^2}{2 \Delta F^*} \right]$$  \hspace{1cm} (3)

centered at $F = F_{\text{def}}^B$, the peak in the data, with a width $\Delta F^* = \frac{1}{2} (F - F_{\text{pre-arc}}^B)$ and normalized to $f_0$. The frequencies have been corrected to reflect only ~0.5 s ammeter data collection interval per 3.5 s at each voltage. $F_{\text{pre-arc}}^B = 160$ ±20 MV/m for LDPE and $F_{\text{pre-arc}}^B = 280$ ±30 MV/m for polyimide. For LDPE $f_0 = 1200\pm400$ MV/m/s, $\Delta F = 80\pm10$ MV/m and $F = 310\pm30$ MV/m. For Kapton $f_0 = 7000\pm3000$ MV/m/s, $\Delta F = 53\pm3$ MV/m and $F = 384\pm17$.

The Gaussian fit is a first-order approximation to the arc rate assuming a random distribution of pre-arcing events with average breakdown, but does not account for removal of specimens from the sample population after breakdown; a more complete theory (like that used for the ESD analysis above) would use the Weibull function to account for these failures and provide a better model near and above the distribution peak. However, to identify the approximate peak and upper bound of the distribution of pre-arcs, and most importantly the lower bound of the pre-arc distribution, this model is sufficient. It has been suggested that the observed Gaussian distribution is related to the flexibility of polyethylene chains in the amorphous regions of LDPE [8]. A similar Gaussian distribution of the mean radius of random polymer coils is predicted from random walk models of chain kink density [24, 25]. This can be related to the entropic contribution to elastic strain energy for basic theories of rubber elasticity [21, 26]. The critical field associated with one defect per activation volume is given by [21]

$$F_{\text{def}} = \left( \frac{2}{\epsilon_0 \epsilon_r} \right) N_{\text{def}} \Delta G_{\text{def}} \frac{F^2}{k_B T}$$  \hspace{1cm} (4)

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Using values for LDPE, \( \Delta C_{def}^{A} = 3.65 \) [23] and \( N_{def}^{A} = 1.75 \times 10^{18} \) cm\(^{-3} \) from fitting static voltage time endurance data [8] \( F_{def} = 320 \text{ MV/m} \) within our uncertainty.

Let us now directly compare \( F_{\text{onset}} \) to \( F_{\text{pre-arching}}^{A} \). A cursory observation of Figs. 3 and 4 suggests that for both LDPE and Kapton ESD breakdown can begin to happen at about the same field as pre-arching is observed in samples that haven’t broken down yet. To make a quantitative comparison we assumed a Gaussian probability for pre-arching up to where the frequency starts to decrease and a Weibull distribution probability for breakdown. Now comparing the fields at which we have a ~5% probability of observing either arcing \( (F_{\text{pre-arching}}^{A}) \) or breakdown \( (F_{\text{onset}}) \) we see that for LDPE \( F_{\text{pre-arching}}^{A} = 160 \pm 20 \text{ MV/m} \approx F_{\text{onset}} = 189 \pm 6 \text{ MV/m} \) and for Kapton \( F_{\text{pre-arching}}^{A} = 280 \pm 30 \text{ MV/m} \approx F_{\text{onset}} = 253 \pm 8 \text{ MV/m} \) within the uncertainty. Transient pre-arcs are consistent with a percolation-like model for recoverable (Type A) defects resulting in a finite probability of breakdown well below more probable breakdown fields [8].

V. CONCLUSIONS

This study of step-up measurements of LDPE and Kapton measurements indicates that the field for the onset of catastrophic ESD breakdown can be estimated as the same field where pre-breakdown arcing begins. Our dual-defect model suggests possible physical origins for the behavior observed in terms of recoverable and irrecoverable defects. Measurements of \( F_{\text{pre-arching}}^{A} \) are considerably easier than measurements of \( F_{\text{onset}} \) since many pre-arcs are generally observed in a single step-up test. Using \( F_{\text{pre-arching}}^{A} \) as an estimate of \( F_{\text{onset}} \) has the potential to expedite diagnostics of insulating materials in practical applications.

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